



### General Description

- Trench Power AlphaSGT™ Technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- Enhanced body diode performance
- RoHS 2.0 and Halogen-Free Compliant

### Applications

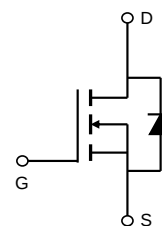
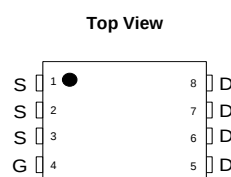
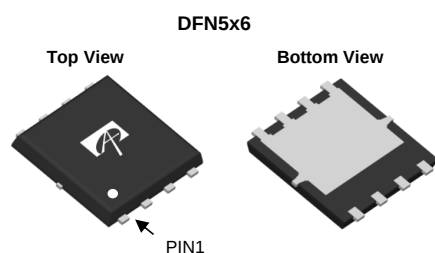
- DC Motor Drive
- Battery Management Systems BMS

### Product Summary

|                                 |                 |
|---------------------------------|-----------------|
| $V_{DS}$                        | 40V             |
| $I_D$ (at $V_{GS}=10V$ )        | 341A            |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ ) | < 1.6m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=6V$ )  | < 2.6m $\Omega$ |

100% UIS Tested  
100% Rg Tested

Max  $T_j=175^{\circ}C$



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AONS77403             | DFN 5x6      | Tape & Reel | 3000                   |

### Absolute Maximum Ratings $T_A=25^{\circ}C$ unless otherwise noted

| Parameter                               | Symbol         | Maximum    | Units       |
|-----------------------------------------|----------------|------------|-------------|
| Drain-Source Voltage                    | $V_{DS}$       | 40         | V           |
| Gate-Source Voltage                     | $V_{GS}$       | $\pm 20$   | V           |
| Continuous Drain Current                | $I_D$          | 341        | A           |
| $T_C=25^{\circ}C$                       |                | 241        |             |
| $T_C=100^{\circ}C$                      |                |            |             |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$       | 1364       |             |
| Avalanche Current <sup>C</sup>          | $I_{AS}$       | 35         | A           |
| Avalanche energy $L=0.3mH$ <sup>C</sup> | $E_{AS}$       | 184        | mJ          |
| Power Dissipation <sup>B</sup>          | $P_D$          | 333        | W           |
| $T_C=25^{\circ}C$                       |                | 167        |             |
| $T_C=100^{\circ}C$                      |                |            |             |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 175 | $^{\circ}C$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max  | Units         |
|--------------------------------------------|-----------------|-----|------|---------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 15  | 20   | $^{\circ}C/W$ |
| $t \leq 10s$                               |                 |     |      |               |
| Maximum Junction-to-Ambient <sup>A D</sup> | $R_{\theta JA}$ | 40  | 50   | $^{\circ}C/W$ |
| Steady-State                               |                 |     |      |               |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | -   | 0.45 | $^{\circ}C/W$ |
| Steady-State                               |                 |     |      |               |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                              | Min  | Typ       | Max        | Units |
|-----------------------------|---------------------------------------|-----------------------------------------------------------------------------------------|------|-----------|------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                         |      |           |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                              | 40   |           |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =40V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                       |      |           | 1<br>5     | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                                              |      |           | ±100       | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                | 2.4  | 2.9       | 3.4        | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                      |      | 1.35<br>2 | 1.6<br>2.4 | mΩ    |
|                             |                                       | V <sub>GS</sub> =6V, I <sub>D</sub> =12.5A                                              |      | 1.95      | 2.6        | mΩ    |
|                             |                                       |                                                                                         |      |           |            |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                                |      | 110       |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                 |      | 0.7       | 1          | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                         |      |           | 200        | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                         |      |           |            |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=200KHz                                     |      | 3550      |            | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                         |      | 1200      |            | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                         |      | 20        |            | pF    |
| R <sub>g</sub>              | Gate resistance                       | f=1MHz                                                                                  | 0.55 | 1.1       | 1.65       | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                         |      |           |            |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =20A                         |      | 45        | 65         | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                         |      | 13        |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                         |      | 7.8       |            | nC    |
| Q <sub>oss</sub>            | Output Charge                         | V <sub>GS</sub> =0V, V <sub>DS</sub> =20V                                               |      | 64        |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, R <sub>L</sub> =1Ω,<br>R <sub>GEN</sub> =3Ω |      | 11        |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                         |      | 3.6       |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                         |      | 29        |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                         |      | 7.8       |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, di/dt=100A/μs                                                      |      | 41        |            | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, di/dt=100A/μs                                                      |      | 27        |            | nC    |

- A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.
- B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Single pulse width limited by junction temperature T<sub>J(MAX)</sub>=175° C.
- D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175° C. The SOA curve provides a single pulse rating.
- G. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

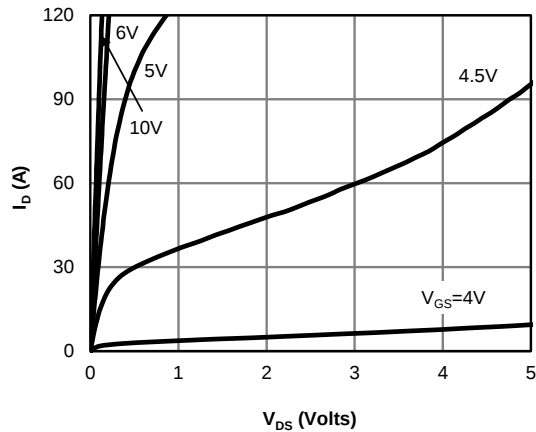


Figure 1: On-Region Characteristics (Note E)

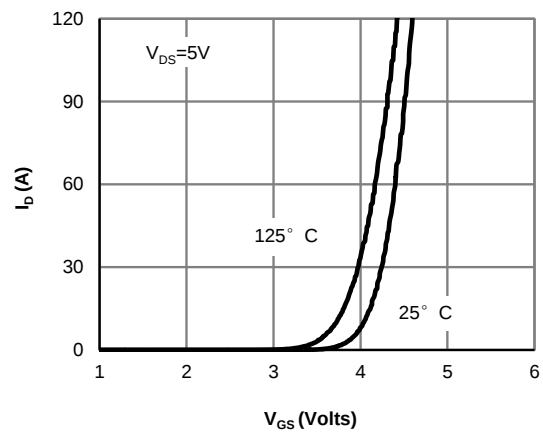


Figure 2: Transfer Characteristics (Note E)

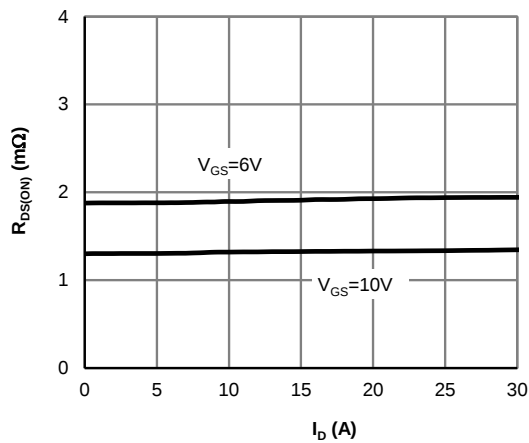


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

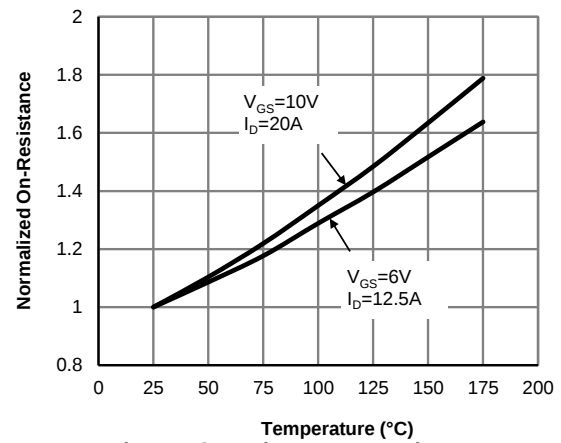


Figure 4: On-Resistance vs. Junction Temperature (Note E)

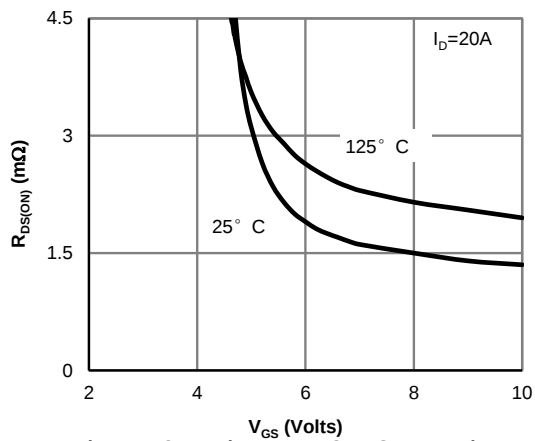


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

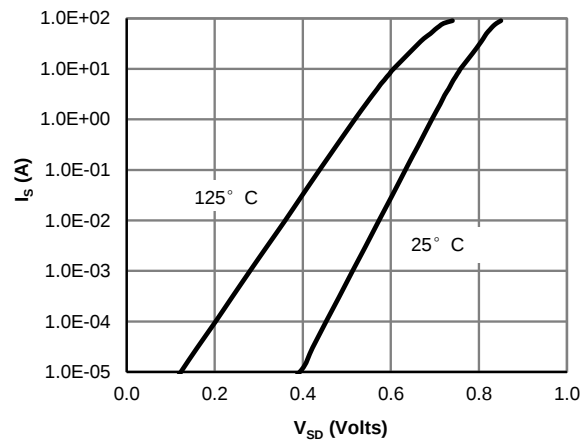
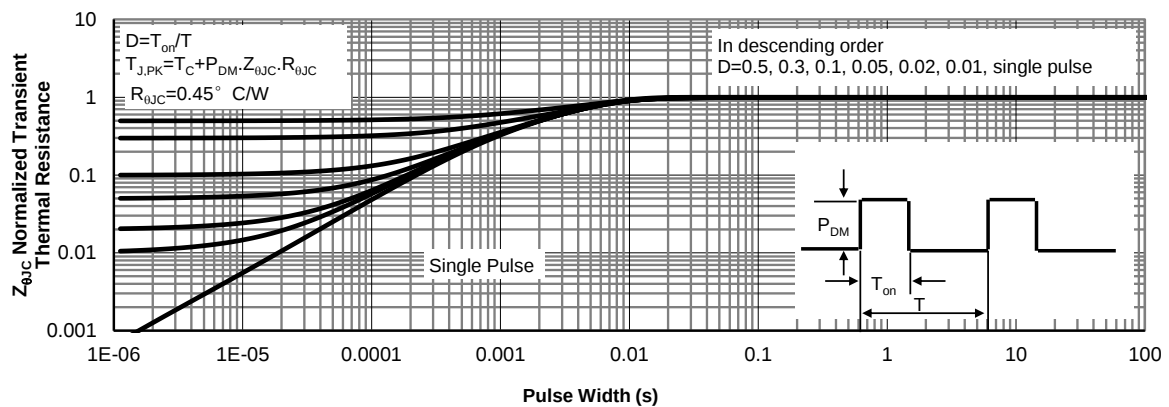
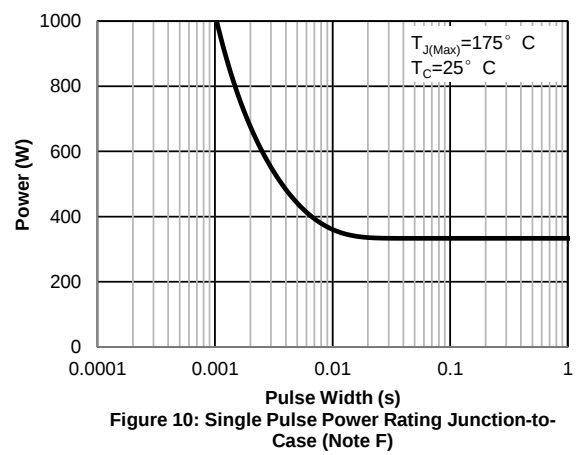
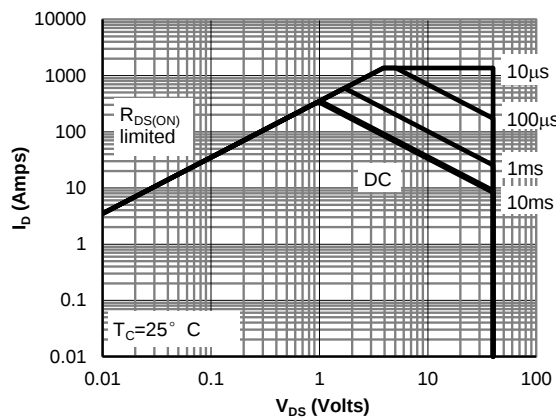
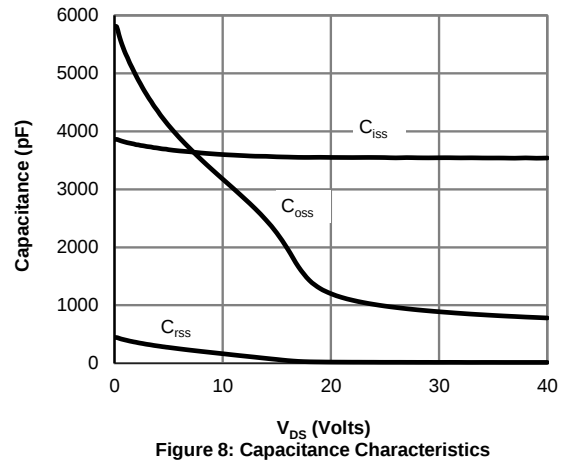
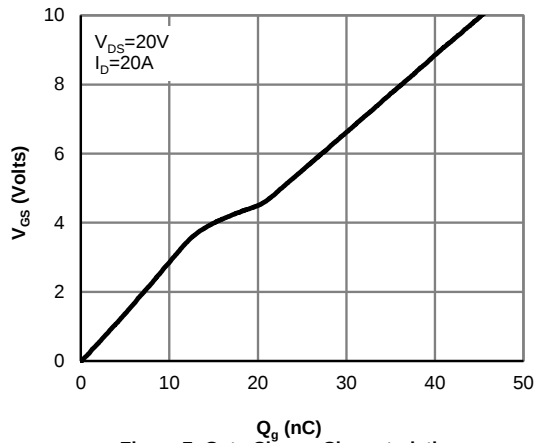


Figure 6: Body-Diode Characteristics (Note E)

# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

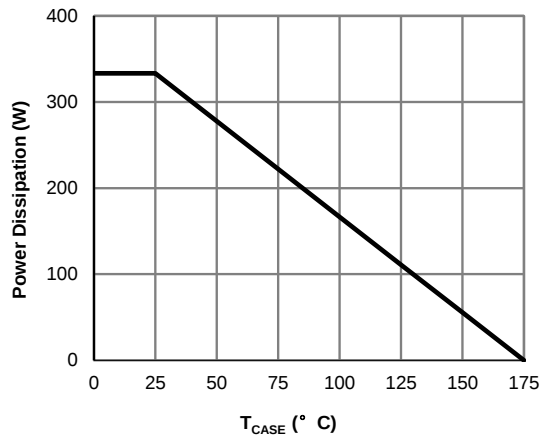


Figure 12: Power De-rating (Note F)

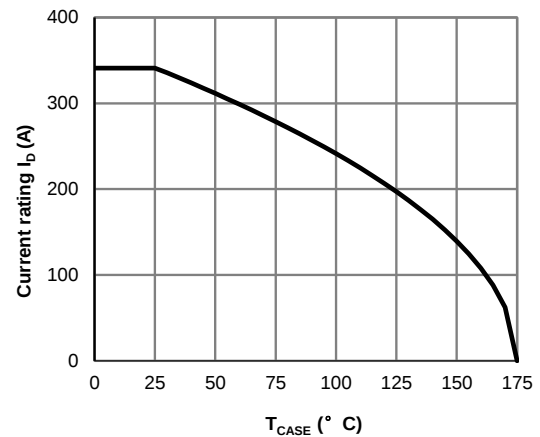


Figure 13: Current De-rating (Note F)

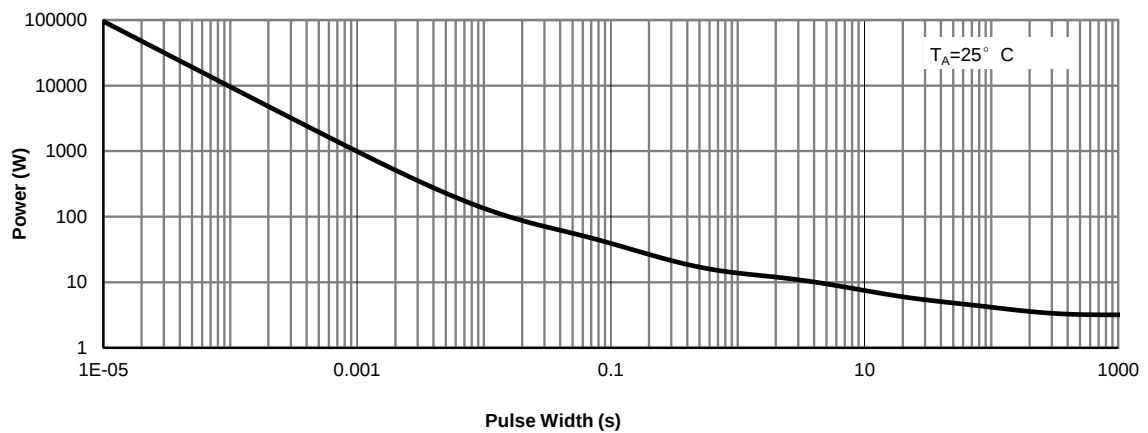


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

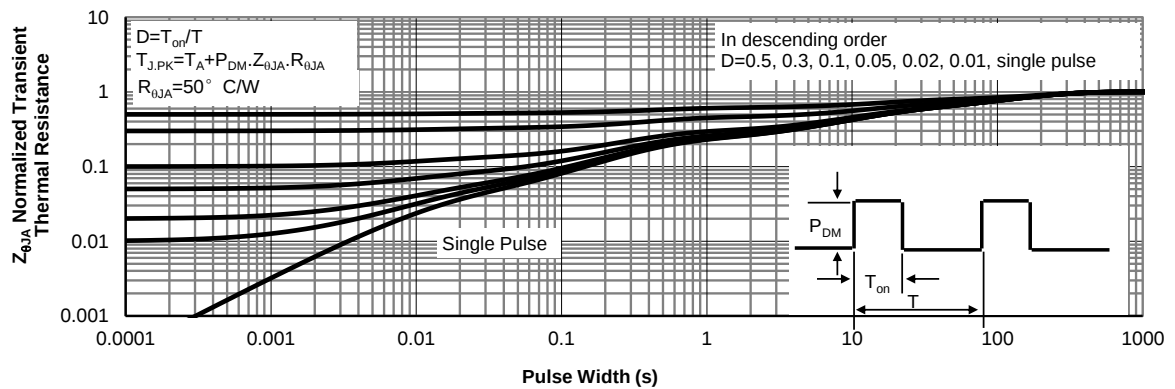


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

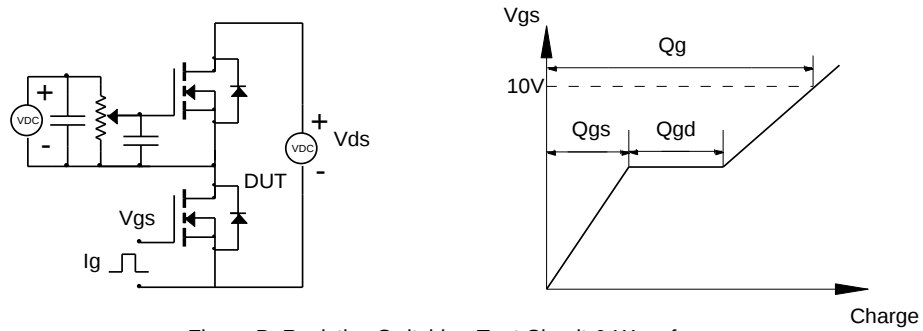


Figure B: Resistive Switching Test Circuit & Waveforms

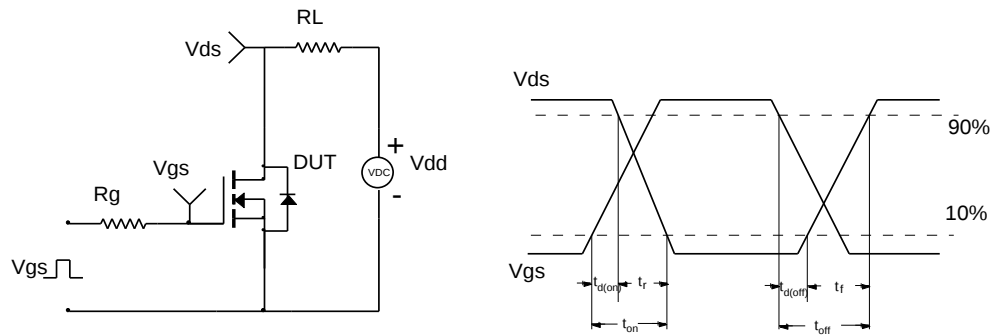


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

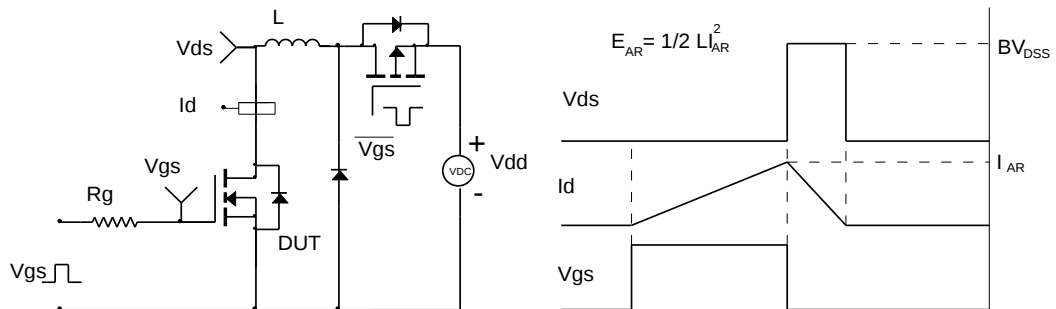


Figure D: Diode Recovery Test Circuit & Waveforms

